

**Search Notes**

Application/Control No.

10/805,297

Examiner

Hieu Nguyen

Applicant(s)/Patent under  
Reexamination

WANG ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	133	7/29/2005	HN
330	310	7/26/2005	HN
330	253	7/26/2005	HN
330	254	7/26/2005	HN
330	282	8/29/2005	HN
330	51	8/1/2005	HN
330	85	8/2/2005	HN
330	86	8/2/2005	HN
330	84	8/2/2005	HN
327	416	8/3/2005	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
MOTTOLA STEVEN J	7/29/2005	HN
MOTTOLA STEVEN J	8/1/2005	HN
MOTTOLA STEVEN J	8/3/2005	HN